Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/813,212	QUMEI, IYAD	
Examiner	Art Unit	Ī
Shin-Hon Chen	2131	

SEARCHED			
Class	Subclass	Date	Examiner
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Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search- see search history)	6/13/2007	S.C.	
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